

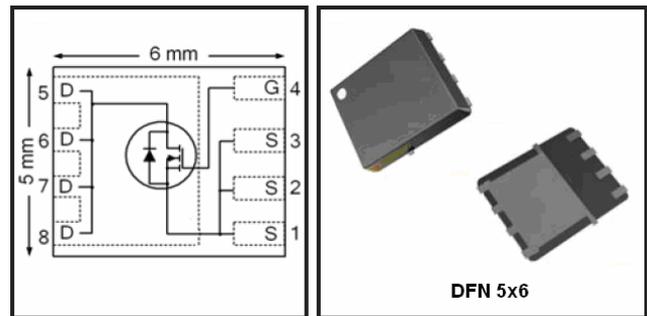
### Features

- ◆ Low On-Resistance
- ◆ Fast Switching
- ◆ 100% Avalanche Tested
- ◆ Repetitive Avalanche Allowed up to Tjmax
- ◆ Green Product, RoHS Compliant

### Description

VS4020AP designed by the trench processing techniques to achieve extremely low on-resistance. Additional features of this design are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Motor applications and a wide variety of other applications.

$V_{DS}$	40	V
$R_{DS(on),Typ}$	4.0	mΩ
$I_D$	60	A



### Absolute Maximum Ratings

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Rating	Unit	
<b>Common Ratings (Tc=25°C Unless Otherwise Noted)</b>				
V <sub>GS</sub>	Gate-Source Voltage	±20	V	
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	40	V	
T <sub>J</sub>	Maximum Junction Temperature	150	°C	
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C	
I <sub>S</sub>	Diode Continuous Forward Current	T <sub>C</sub> = 25°C	60	A
<b>Mounted on Large Heat Sink</b>				
I <sub>DM</sub>	Pulse Drain Current Tested (Silicon Limit)	T <sub>C</sub> = 25°C	180	A
I <sub>D</sub>	Continuous Drain current@V <sub>GS</sub> =10V (See Fig2)	T <sub>C</sub> = 25°C	60	A
P <sub>D</sub>	Maximum Power Dissipation	T <sub>C</sub> = 25°C	60	W
R <sub>θJA</sub>	Thermal Resistance-Junction to Ambient		1.68	°C/W
<b>Drain-Source Avalanche Ratings</b>				
EAS	Avalanche Energy, Single Pulsed ②		225	mJ

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	40	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current(Tc=25°C)	V <sub>DS</sub> =32V, V <sub>GS</sub> =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(Tc=125°C)	V <sub>DS</sub> =32V, V <sub>GS</sub> =0V	--	--	100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	--	--	±100	nA
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	2.0	2.5	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance①	V <sub>GS</sub> =10V, I <sub>D</sub> =30A	--	4.0	5.5	mΩ
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance①	V <sub>GS</sub> =4.5V, I <sub>D</sub> =15A	--	5.5	6.5	mΩ
<b>Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, Frequency=1MHz	--	2250	--	pF
C <sub>oss</sub>	Output Capacitance		--	320	--	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	195	--	pF
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> =10V	--	39	--	nC
		V <sub>GS</sub> =4.5V	--	23	--	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =20V, I <sub>D</sub> =20A, V <sub>GS</sub> =10V	--	7.5	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	9.8	--	nC
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =20V, I <sub>D</sub> =10A, R <sub>G</sub> =6.8Ω, V <sub>GS</sub> =10V	--	16.5	--	nS
t <sub>r</sub>	Turn-on Rise Time		--	17.5	--	nS
t <sub>d(off)</sub>	Turn-Off Delay Time		--	24	--	nS
t <sub>f</sub>	Turn-Off Fall Time		--	16	--	nS
<b>Source- Drain Diode Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)</b>						
I <sub>SD</sub>	Source-drain current(Body Diode)	T <sub>c</sub> =25°C	--	--	60	A
V <sub>SD</sub>	Forward on voltage	I <sub>SD</sub> =30A, V <sub>GS</sub> =0V	--	--	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	T <sub>J</sub> =25°C, I <sub>sd</sub> =30A, V <sub>GS</sub> =0V	--	26	--	nS
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt=100A/μs		15	--	nC

NOTE:

① Pulse width ≤ 300μs; duty cycles ≤ 2%.

② Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 0.5mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 30A, V<sub>GS</sub> = 10V.

Part not recommended for use above this value

③ Repetitive rating; pulse width limited by max. junction temperature.

Typical Characteristics

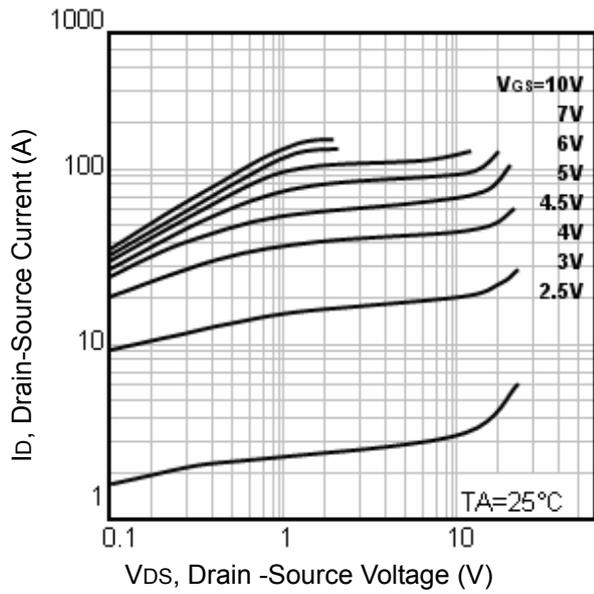


Fig1. Typical Output Characteristics

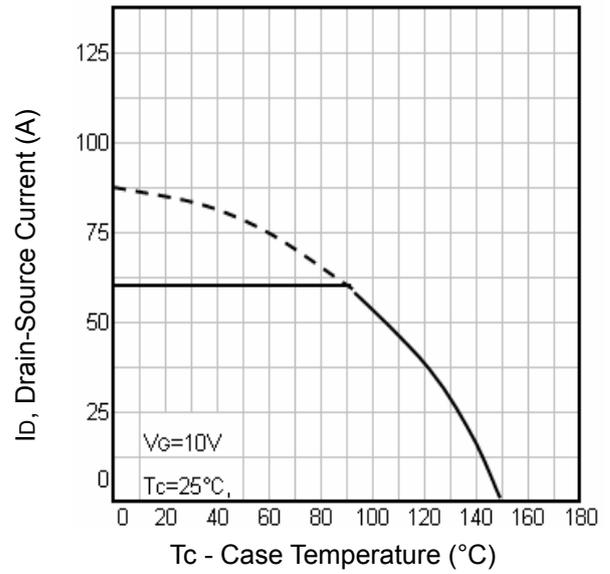


Fig2. Maximum Drain Current Vs. Case Temperature

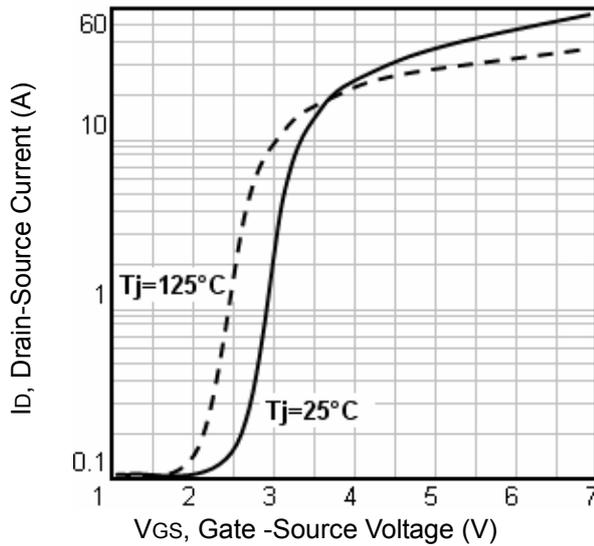


Fig3. Typical Transfer Characteristics

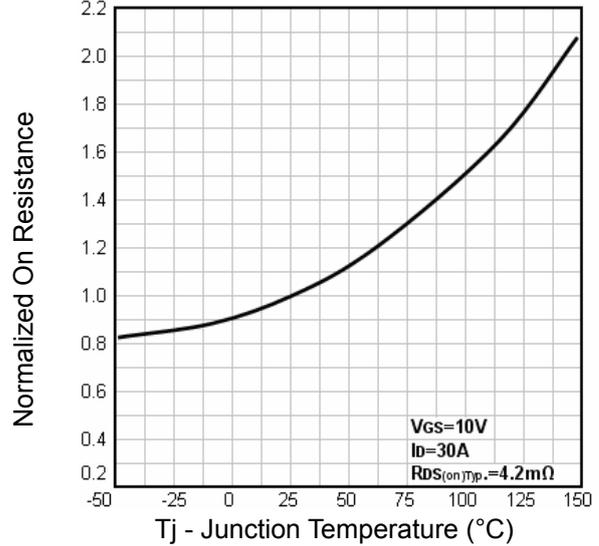


Fig4. Normalized On-Resistance Vs. Temperature

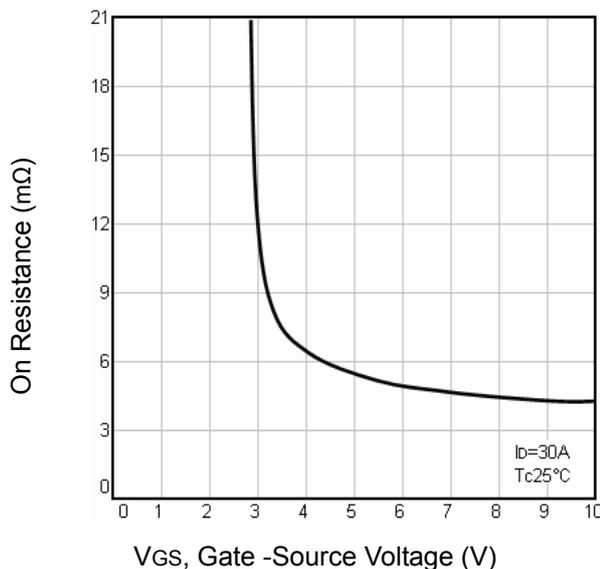


Fig5. On Resistance Vs. Gate-Source Voltage

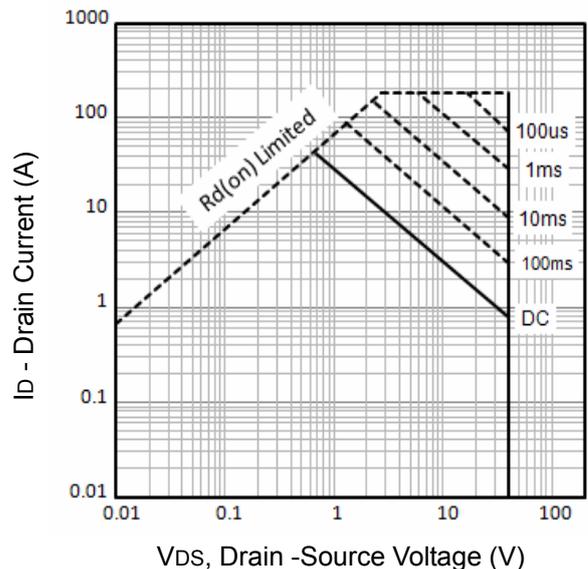


Fig6. Maximum Safe Operating Area

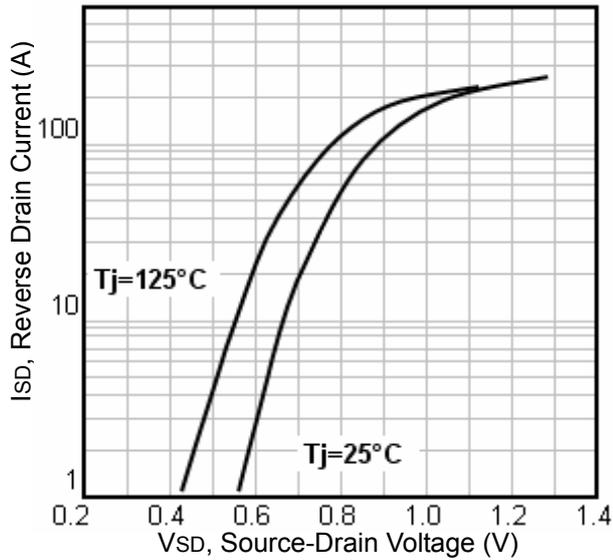


Fig7. Typical Source-Drain Diode Forward Voltage

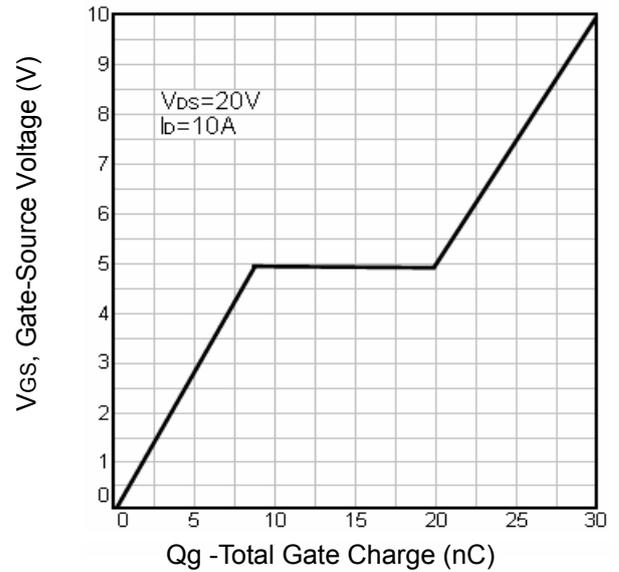


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

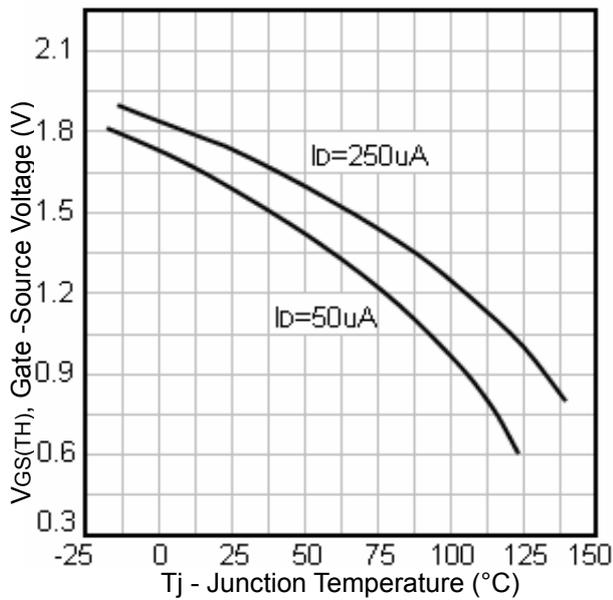


Fig9. Threshold Voltage Vs. Temperature

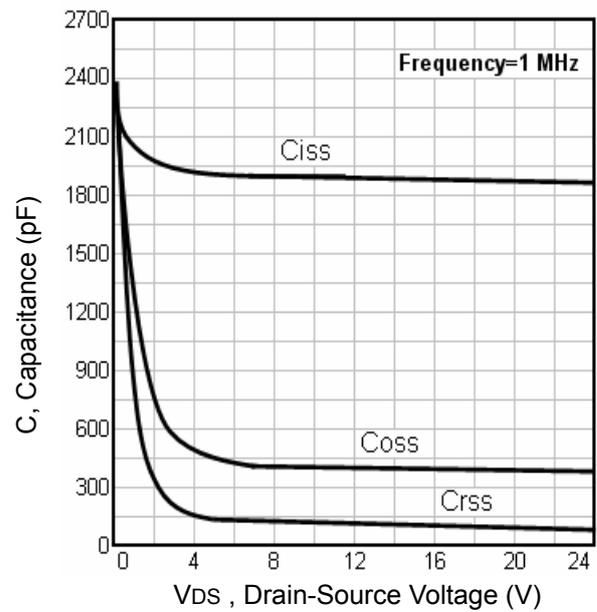


Fig10. Typical Capacitance Vs. Drain-Source Voltage

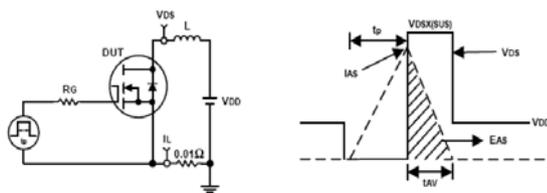


Fig11. Unclamped Inductive Test Circuit and waveforms

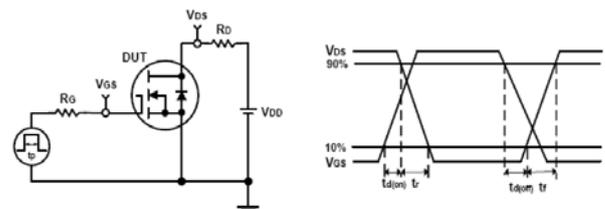
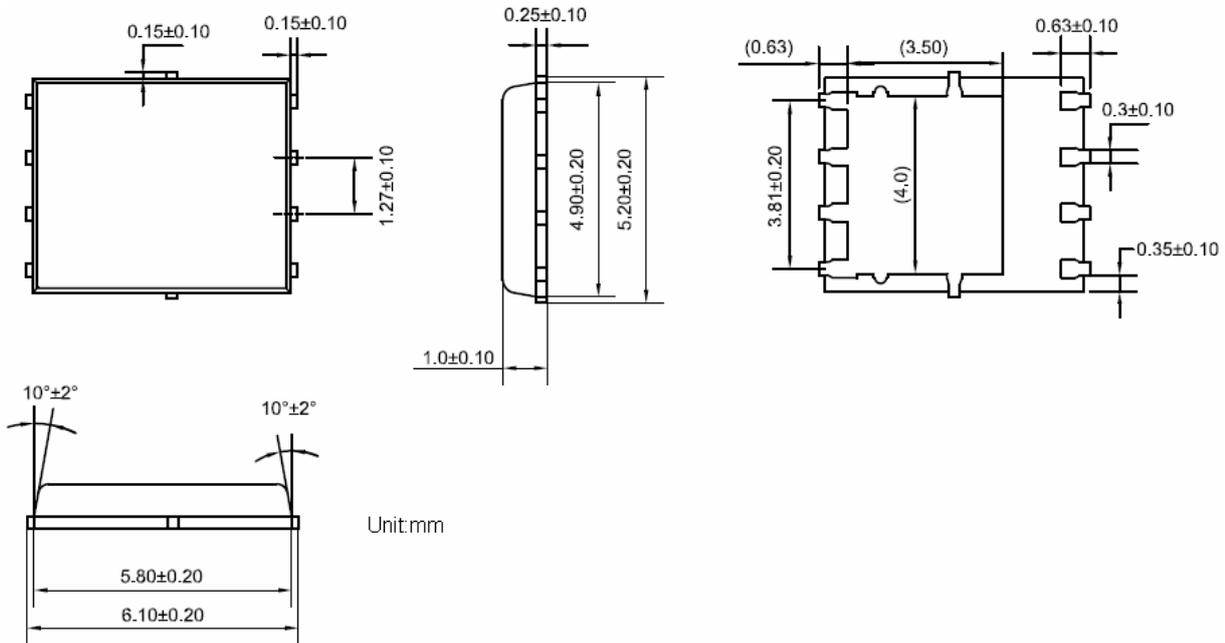


Fig12. Switching Time Test Circuit and waveforms

**DFN5X6 Package Outline**



**Marking**



Logo  
Product Name  
XXX: Product Lot Code; YWW: Year and week Code

**Order Information**

Product	Package	Packaging	Min Unit Quantity
VS4020AP	DFN5X6	3000PCS/Reel	6000PCS

**Customer Service**

**Sales and Service:**  
sales@vgsemi.com

**Shen Zhen Vanguard Semiconductor CO., LTD**

**TEL:** (86-755) -26902410

**FAX:** (86-755) -26907027

**WEB:** www.vgsemi.com